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# **TOSHIBA**

TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

# TC74LCX541F,TC74LCX541FW,TC74LCX541FT,TC74LCX541FK

Low-Voltage Octal Bus Buffer with 5-V Tolerant Inputs and Outputs

The TC74LCX541F/FW/FT/FK is a high-performance CMOS octal bus buffer. Designed for use in 3.3-V systems, it achieves high-speed operation while maintaining the CMOS low power dissipation.

The device is designed for low-voltage  $(3.3 \text{ V}) \text{ V}_{CC}$  applications, but it could be used to interface to 5 V supply environment for both inputs and outputs.

The TC74LCX541F/FW/FT is a non-inverting 3-state buffer having two active-low output enables. When either  $\overline{\text{OE1}}$  or  $\overline{\text{OE2}}$  are high, the terminal outputs are in the high-impedance state. This device is designed to be used with 3-state memory address drivers, etc.

All inputs are equipped with protection circuits against static discharge.

#### Features

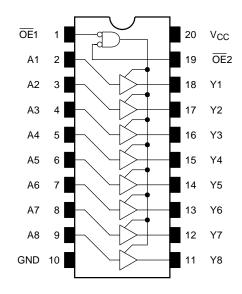
- Low-voltage operation: VCC = 2.0 to 3.6 V
- High-speed operation:  $t_{pd} = 6.5 \text{ ns} (\text{max}) (V_{CC} = 3.0 \text{ to } 3.6 \text{ V})$
- Output current:  $|I_{OH}|/I_{OL} = 24 \text{ mA} (min) (V_{CC} = 3.0 \text{ V})$
- Latch-up performance: ±500 mA
- Available in JEDEC SOP, JEITA SOP and TSSOP
- · Power-down protection provided on all inputs and outputs
- Pin and function compatible with the 74 series (74AC/VHC/HC/F/ALS/LS etc.) 541 type

Note: xxxFW (JEDEC SOP) is not available in Japan.
TC74LCX541F
TRANCING
SOP20-P-300-1.27A
TURTURRUNU
SOP20-P-300-1.27 TC74LCX541FW
THUTTURE
SOL20-P-300-1.27 TC74LCX541FT
CLARENCE
TSSOP20-P-0044-0.65A TC74LCX541FK
TRANSPORT
VSSOP20-P-0030-0.50

Weight	
SOP20-P-300-1.27A	: 0.22 g (typ.)
SOP20-P-300-1.27	: 0.22 g (typ.)
SOL20-P-300-1.27	: 0.46 g (typ.)
TSSOP20-P-0044-0.65A	: 0.08 g (typ.)
VSSOP20-P-0030-0.50	: 0.03 g (typ.)

# <u>TOSHIBA</u>

# Pin Assignment (top view)



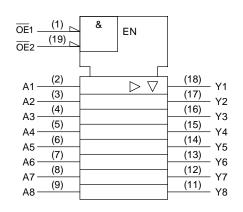
# Truth Table

	Inputs	uts Outputs		
OE1	OE2	An	Outputs	
н	Х	Х	Z	
Х	Н	Х	Z	
L	L	н	н	
L	L	L	L	

#### X: Don't care

Z: High impedance

# **IEC Logic Symbol**



# Absolute Maximum Ratings (Note 1)

Characteristics	Symbol	Rating	Unit
Power supply voltage	V <sub>CC</sub>	-0.5 to 7.0	V
DC input voltage	V <sub>IN</sub>	-0.5 to 7.0	V
		-0.5 to 7.0 (Note 2)	
DC output voltage	V <sub>OUT</sub>	-0.5 to V <sub>CC</sub> + 0.5	V
		(Note 3)	
Input diode current	I <sub>IK</sub>	-50	mA
Output diode current	I <sub>OK</sub>	±50 (Note 4)	mA
DC output current	IOUT	±50	mA
Power dissipation	PD	180	mW
DC V <sub>CC</sub> /ground current	I <sub>CC</sub> /I <sub>GND</sub>	±100	mA
Storage temperature	T <sub>stg</sub>	-65 to 150	

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Note 2: Output in OFF state

- Note 3: High or low state. IOUT absolute maximum rating must be observed.
- Note 4:  $V_{OUT} < GND, V_{OUT} > V_{CC}$

#### **Recommended Operating Conditions (Note 1)**

Characteristics	Symbol	Rating	Unit	
Power supply voltage	V <sub>CC</sub>	2.0 to 3.6	V	
Fower supply voltage	VCC	1.5 to 3.6 (Note 2)	v	
Input voltage	V <sub>IN</sub>	0 to 5.5	V	
Output voltage	Vout	0 to 5.5 (Note 3)	V	
	V001	0 to V <sub>CC</sub> (Note 4)	v	
Output current	lau/lau	±24 (Note 5)	mA	
Culput cullent	IOH/IOL	±12 (Note 6)	mA	
Operating temperature	T <sub>opr</sub>	-40 to 85	°C	
Input rise and fall time	dt/dv	0 to 10 (Note 7)	ns/V	

Note 1: The recommended operating conditions are required to ensure the normal operation of the device. Unused inputs must be tied to either VCC or GND.

Note 2: Data retention only

- Note 3: Output in OFF state
- Note 4: High or low state
- Note 5:  $V_{CC} = 3.0$  to 3.6 V
- Note 6:  $V_{CC} = 2.7$  to 3.0 V
- Note 7:  $V_{IN}=0.8 \mbox{ to } 2.0 \mbox{ V}, \mbox{ } V_{CC}=3.0 \mbox{ V}$

#### **Electrical Characteristics**

#### DC Characteristics (Ta = -40 to 85°C)

Characte	ristics	Symbol	Test Condition		Test Condition		Test Condition		V <sub>CC</sub> (V)	Min	Max	Unit
	H-level	VIH	_		2.7 to 3.6	2.0						
Input voltage	L-level	VIL	_	_	2.7 to 3.6		0.8	V				
				I <sub>OH</sub> = -100 μA	2.7 to 3.6	V <sub>CC</sub> - 0.2	_					
	H-level	V <sub>OH</sub>	$V_{IN} = V_{IH} \text{ or } V_{IL}$	$I_{OH} = -12 \text{ mA}$	2.7	2.2						
		-		I <sub>OH</sub> = -18 mA	3.0	2.4	_					
Output voltage				$I_{OH} = -24 \text{ mA}$	3.0	2.2	_	V				
		I <sub>OL</sub> = 100 μA	$V_{OL}$ $V_{IN} = V_{IH} \text{ or } V_{IL}$	$I_{OL} = 100 \ \mu A$	2.7 to 3.6	_	0.2					
	L-level	Va		$I_{OL} = 12 \text{ mA}$	2.7	_	0.4					
	L-level	VOL		$I_{OL} = 16 \text{ mA}$	3.0	_	0.4					
				$I_{OL} = 24 \text{ mA}$	3.0	_	0.55					
Input leakage curre	nt	I <sub>IN</sub>	V <sub>IN</sub> = 0 to 5.5 V		2.7 to 3.6	_	±5.0	μA				
3-state output off-state current		I <sub>OZ</sub>	$V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{OUT} = 0 \text{ to } 5.5 \text{ V}$		2.7 to 3.6	_	±5.0	μА				
Power off leakage of	eakage current I <sub>OFF</sub>		$V_{IN}/V_{OUT} = 5.5 V$		0	_	10.0	μΑ				
	$V_{IN} = V_{CC}$ or GND		$V_{IN} = V_{CC} \text{ or } GND$		2.7 to 3.6		10.0					
Quiescent supply cu		Icc	$V_{IN}/V_{OUT} = 3.6 \text{ to } 5.5 \text{ V}$		2.7 to 3.6	_	±10.0	μA				
Increase in I <sub>CC</sub> per	input	$\Delta I_{CC}$	$V_{IH} = V_{CC} - 0.6 \text{ V}$		2.7 to 3.6		500					

#### AC Characteristics (Ta = -40 to 85°C)

Characteristics	Symbol	Test Condition	V <sub>CC</sub> (V)	Min	Max	Unit
Propagation delay time	t <sub>pLH</sub>	Figure 1, Figure 2	2.7	_	7.5	ns
riopagation delay time	t <sub>pHL</sub>		$\textbf{3.3}\pm\textbf{0.3}$	1.5	6.5	115
Output enable time	t anabla tima	2.7	_	9.5	ns	
	t <sub>pZH</sub>	Figure 1, Figure 3	$\textbf{3.3}\pm\textbf{0.3}$	1.5	8.5	115
Output disable time	t <sub>pLZ</sub>	Figure 1, Figure 3	2.7	_	8.5	ns
	t <sub>pHZ</sub>		$\textbf{3.3}\pm\textbf{0.3}$	1.5	7.5	115
Output to output skew	t <sub>osLH</sub>	(Note) -	2.7			ns
	t <sub>osHL</sub>	(Note)	$\textbf{3.3}\pm\textbf{0.3}$		1.0	115

Note: Parameter guaranteed by design.

 $(t_{OSLH} = |t_{PLHm} - t_{PLHn}|, t_{OSHL} = |t_{PHLm} - t_{PHLn}|)$ 

### Dynamic Switching Characteristics (Ta = 25°C, input: $t_r = t_f = 2.5$ ns, $C_L = 50$ pF, $R_L = 500$ $\Omega$ )

Characteristics		Symbol	Test Condition	V <sub>CC</sub> (V)	Тур.	Unit
Quiet output maximum dynamic	V <sub>OL</sub>	V <sub>OLP</sub>	$V_{IH} = 3.3 \text{ V}, \ V_{IL} = 0 \text{ V}$	3.3	0.8	V
Quiet output minimum dynamic	V <sub>OL</sub>	Volv	$V_{IH} = 3.3 \text{ V}, \text{ V}_{IL} = 0 \text{ V}$	3.3	0.8	V

#### **Capacitive Characteristics (Ta = 25°C)**

Characteristics	Symbol	Test Condition	V <sub>CC</sub> (V)	Тур.	Unit
Input capacitance	C <sub>IN</sub>	_	3.3	7	pF
Output capacitance	C <sub>OUT</sub>		3.3	8	pF
Power dissipation capacitance	C <sub>PD</sub>	f <sub>IN</sub> = 10 MHz (No	e) 3.3	40	pF

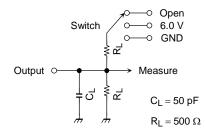
Note: C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption.

Average operating current can be obtained by the equation:

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/8 \text{ (per bit)}$ 

# <u>TOSHIBA</u>

# **AC Test Circuit**



Parameter	Switch
t <sub>pLH</sub> , t <sub>pHL</sub>	Open
t <sub>pLZ</sub> , t <sub>pZL</sub>	6.0 V
t <sub>pHZ</sub> , t <sub>pZH</sub>	GND



#### **AC Waveform**

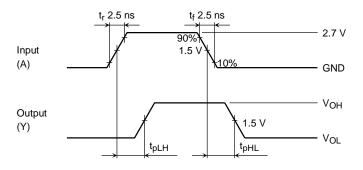
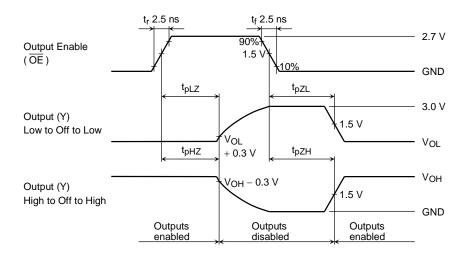
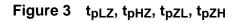


Figure 2 t<sub>pLH</sub>, t<sub>pHL</sub>

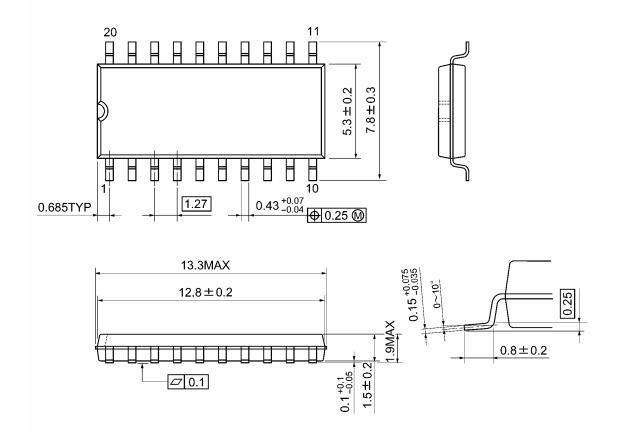




# Package Dimensions

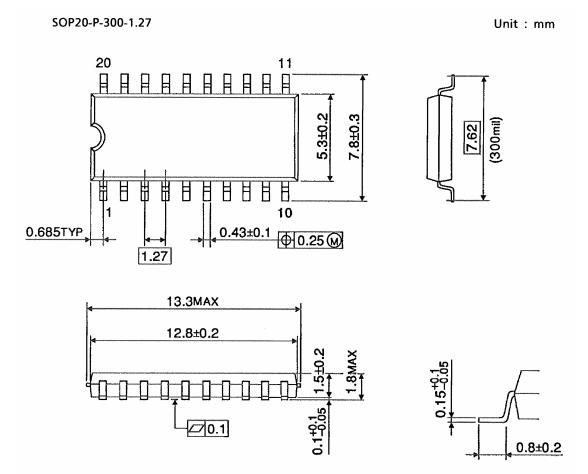
SOP20-P-300-1.27A

Unit: mm



Weight: 0.22 g (typ.)

#### **Package Dimensions**

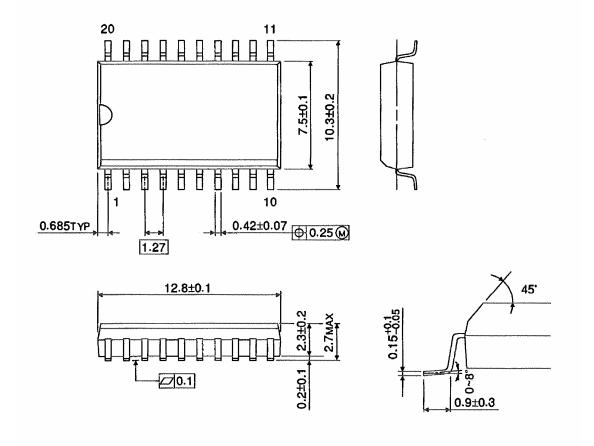


Weight: 0.22 g (typ.)

# Package Dimensions (Note)

SOL20-P-300-1.27

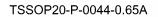
Unit : mm



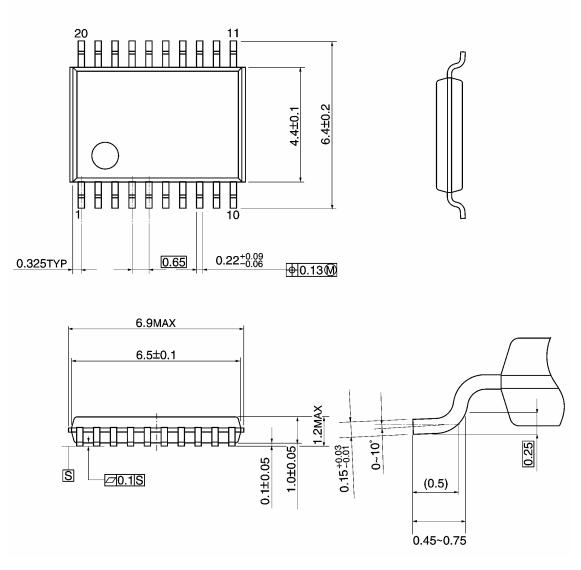
Note: This package is not available in japan.

Weight: 0.46 g (typ.)

# Package Dimensions



Unit: mm



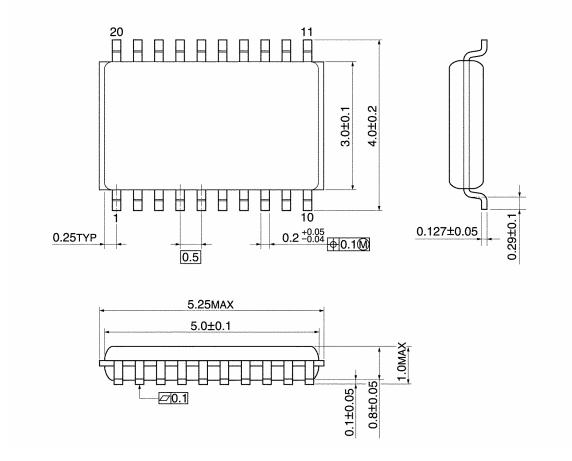
Weight: 0.08 g (typ.)

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# Package Dimensions

VSSOP20-P-0030-0.50

Unit: mm



Weight: 0.03 g (typ.)

Note: Lead (Pb)-Free Packages SOP20-P-300-1.27A TSSOP20-P-0044-0.65A VSSOP20-P-0030-0.50

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Handbook" etc. 021023\_A

060116EBA

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